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## PREPARATION OF Y-Ba-Cu-O SUPERCONDUCTING FILMS ON $\text{SrTiO}_3$ AND MgO SUBSTRATES BY CHEMICAL VAPOR DEPOSITION

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**Abstract** YBaCuO superconducting films were prepared at  $850^\circ\text{C}$  on  $\text{SrTiO}_3(100)$  and  $\text{MgO}(100)$  by chemical vapor deposition using  $\beta$ -diketone metal chelates. The films deposited on  $\text{SrTiO}_3(100)$  showed  $T_c$  of 87-92 K and  $J_c$  above  $10^5 \text{ A/cm}^2$  at 77.3 K and 0 T,  $T_c$  and  $J_c$  of the films on  $\text{MgO}(100)$  were 80-89 K and below  $10^4 \text{ A/cm}^2$  at 77.3 K and 0 T, respectively.

### INTRODUCTION

Y-Ba-Cu-O(YBaCuO) superconducting films have already been prepared using various techniques in order to investigate their physical properties and their usability for applications<sup>1-3</sup>.  $\text{SrTiO}_3$  and MgO single crystals are widely used as substrate materials for YBaCuO films. Critical current densities( $J_c$ ) higher than  $10^5 \text{ A/cm}^2$  at 77.3 K and 0 T have already been reported for films prepared by chemical vapor deposition(CVD) on  $\text{SrTiO}_3(100)$  substrates. Critical current densities in the range of  $10^4 \text{ A/cm}^2$  at 77.3 K and magnetic fields up to 27 T were also measured for CVD-YBaCuO films<sup>4,5</sup>. However, the  $J_c$  of the CVD-YBaCuO films on MgO has not yet been reported. This paper is concerned with the structure and superconducting properties of CVD-YBaCuO films prepared on  $\text{SrTiO}_3(100)$  and  $\text{MgO}(100)$ .

### EXPERIMENTAL

The  $\beta$ -diketonates used as source materials were  $\text{Y}(\text{thd})_3$ ,  $\text{Ba}(\text{thd})_2$  and  $\text{Cu}(\text{thd})_2$  (where (thd) represents 2,2,6,6-tetramethyl-3,5-

heptanedionato). The evaporation temperatures of the source materials were in the range of 115-255°C. Each evaporated source was introduced with Ar gas (total 450 ml/min) into a hot-wall CVD reactor. Oxygen gas(250 ml/min) was separately introduced into the reactor. Total gas pressure was maintained at 10 Torr during the deposition. Deposition temperature and time were 850°C and 1 h, respectively.

After deposition, the films were cooled down from 850°C to room temperature at a rate of 15°C/min under 1 atm of oxygen(in-situ oxygen treatment). Substrates used were SrTiO<sub>3</sub>(100) and MgO(100) single crystals(5x10x1 mm<sup>3</sup>).

X-ray diffraction (XRD) patterns of the deposited films were obtained by the standard 2θ-θ method. The resistivity and the critical current of the films were measured by a DC four-probe method with Au electrodes sputtered on the film. Analysis of the film composition was carried out by Auger electron spectroscopy(AES).

## RESULTS AND DISCUSSION

The XRD patterns of CVD-YBaCuO films on SrTiO<sub>3</sub>(100) and MgO(100) are shown in Figure 1(a) and (b). Observed high relative intensities of (001) peaks indicate that the c-axis is oriented perpendicular to the substrate.

Table I summarizes the c-axis lengths calculated from the (007) peak position, integral widths (PIW) of the (007) peak, and integral widths of the rocking curve (RIW) for the (007) peak. The c-axis length of the film on SrTiO<sub>3</sub>(100) was smaller than that of the film on MgO(100). However, the integral widths of the films on SrTiO<sub>3</sub>(100) and MgO(100) were almost the same. The crystallite size evaluated from the integral width was above 2000 Å. The film on MgO(100) has a larger integral width of the rocking curve compared to the film on SrTiO<sub>3</sub>(100). This indicates that the degree of the c-axis orientation of the film on MgO(100) is lower than that for the film on SrTiO<sub>3</sub>(100). The reason for this behavior may be ascribed to the large lattice mismatch

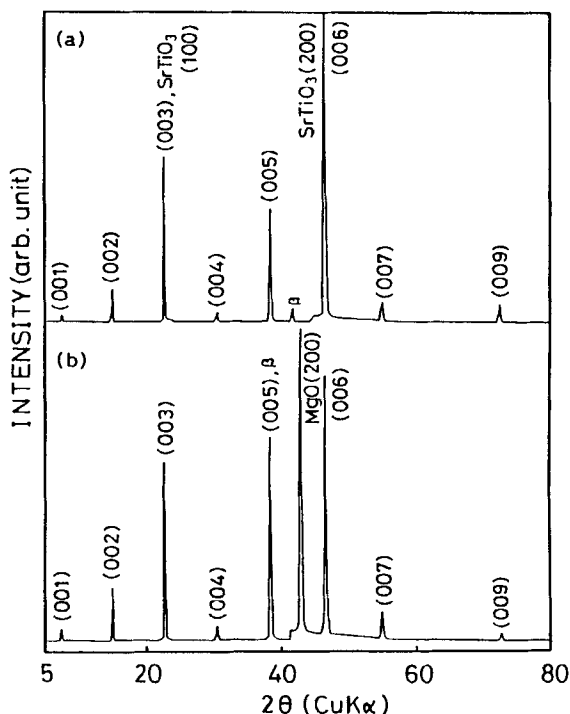


FIGURE 1 X-ray diffraction patterns of CVD-YBaCuO films on  $\text{SrTiO}_3(100)$  and  $\text{MgO}(100)$ .

TABLE I XRD data of YBaCuO films

	$\text{SrTiO}_3(100)$	$\text{MgO}(100)$
$c_0$ (Å)	11.683	11.693
PIW(007) ( $2\theta$ )	$0.23^\circ$	$0.24^\circ$
RIW(007) ( $\theta$ )	$0.46^\circ$	$0.66^\circ$

PIW: integral width of a peak

RIW: integral width of a rocking curve

between  $\text{YBa}_2\text{Cu}_3\text{O}_y$  and  $\text{MgO}(8-10\%)$  compared to the mismatch between  $\text{YBa}_2\text{Cu}_3\text{O}_y$  and  $\text{SrTiO}_3(2\%)$ . Another reason may be due to differences in the single crystal perfection of the substrates.

The temperature dependence of the resistivity of the films on

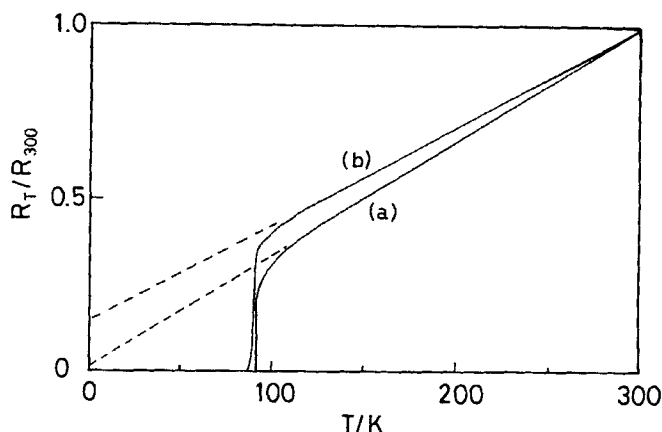


FIGURE 2 Normalized resistivity versus temperature of CVD-YBaCuO films on  $\text{SrTiO}_3(100)$  (a) and  $\text{MgO}(100)$  (b).

$\text{SrTiO}_3(100)$  and  $\text{MgO}(100)$  is shown in Figure 2. The resistivity of both samples decreases linearly with decreasing temperature, but the transition width of the film on  $\text{SrTiO}_3$  was smaller compared to the YBaCuO film on  $\text{MgO}$ . Superconducting transition temperature  $T_c$  (resistivity zero:  $R=0$ ) of the films on  $\text{SrTiO}_3(100)$  and  $\text{MgO}(100)$  are at 92 K and 86 K, respectively.

$T_c(R=0)$  of the films prepared on  $\text{MgO}(100)$  was lower than that of the films on  $\text{SrTiO}_3(100)$  and did not exceed 90 K. Komatsu et al.<sup>6</sup> and Yan et al.<sup>7</sup> reported that impurities of Sr, Ti and Mg had decreased the  $T_c$  of  $\text{YBa}_2\text{Cu}_3\text{O}_{7-x}$  and shortened the c-axis length. However, we could not detect these impurities in the films by AES analysis. Moreover, the CVD-YBaCuO film on  $\text{MgO}(100)$  with lower  $T_c(R=0)$  had a larger c-axis length than the films on  $\text{SrTiO}_3(100)$ .

It is well-known that the oxygen deficiency of  $\text{YBa}_2\text{Cu}_3\text{O}_y$  reduces  $T_c$  and expands c-axis length<sup>8</sup>. The  $T_c$  and c-axis length in the present study agree with the reported values. The oxygen content in the films on  $\text{MgO}(100)$  might be lower than that in the films on  $\text{SrTiO}_3(100)$ , although the films on both substrates received the same in-situ oxygen treatment after deposition. We suppose that this might be caused by the difference in the degree of c-axis orientation or in the discrepancies of the thermal expansion coefficient between the film and substrate.

The highest  $J_c$  value measured at 77 K and 0 T among the films on SrTiO<sub>3</sub>(100) and MgO(100) were  $2.0 \times 10^6$  and  $8.0 \times 10^3$  A/cm<sup>2</sup>, respectively. It was reported that the misorientation of the YBa<sub>2</sub>Cu<sub>3</sub>O<sub>y</sub> grains depressed the values of  $J_c$ <sup>9</sup>. The low  $J_c$  of the films on MgO(100) may be related to the deviation of c-axis orientation.

To summarize, YBaCuO superconducting films were prepared by CVD.  $T_c$  and  $J_c$  of the films on SrTiO<sub>3</sub>(100) were superior to those on MgO(100). The films on SrTiO<sub>3</sub>(100) had  $T_c(R=0)$  of 87-92 K and  $J_c$  of  $10^5$ - $10^6$  A/cm<sup>2</sup> at 77.3 K and 0 T.

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